


<b>Search Notes</b>  	<b>Application/Control No.</b>  10534494	<b>Applicant(s)/Patent Under Reexamination</b>  LEWIN ET AL.
	<b>Examiner</b>  Luu, Thanh X	<b>Art Unit</b>  2878

SEARCHED			
Class	Subclass	Date	Examiner
250	221, 222.1	1/10/2008	/TXL/
356	4.01-4.09	1/10/2008	/TXL/

SEARCH NOTES		
Search Notes	Date	Examiner
see updated EAST text search notes	1/10/2008	/TXL/

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner